

Notice of References Cited	Application/Control No. 10/580,441		Applicant(s)/Patent Under Reexamination NESWAL, PETER	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,897,638 A	04-1999	Lasser et al.	1/1
*	B	US-5,903,753 A	05-1999	Bramnick et al.	719/328
*	C	US-6,064,813 A	05-2000	Sitbon et al.	717/100
*	D	US-6,151,643 A	11-2000	Cheng et al.	710/36
*	E	US-6,266,811 B1	07-2001	Nabahi, Narimane	717/174
*	F	US-2001/0042112 A1	11-2001	Slivka et al.	709/220
*	G	US-6,353,926 B1	03-2002	Parthesarathy et al.	717/170
*	H	US-6,389,589 B1	05-2002	Mishra et al.	717/170
*	I	US-2002/0067504 A1	06-2002	Salgado et al.	358/1.15
*	J	US-2002/0083430 A1	06-2002	Kusuda et al.	717/174
*	K	US-6,418,554 B1	07-2002	Delo et al.	717/174
*	L	US-6,578,076 B1	06-2003	Putzolu, David Matthew	709/223
*	M	US-2003/0195949 A1	10-2003	Slivka et al.	709/219

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0233649 A1	12-2003	Reimert, Scott	717/176
*	B	US-6,684,242 B1	01-2004	Bahlmann, Bruce F.	709/222
*	C	US-2004/0015961 A1	01-2004	Chefalas et al.	717/178
*	D	US-2004/0015949 A1	01-2004	Taylor, Julian S.	717/171
*	E	US-6,742,028 B1	05-2004	Wang et al.	709/223
*	F	US-6,931,546 B1	08-2005	Kouznetsov et al.	726/23
*	G	US-2006/0101095 A1	05-2006	Episale et al.	707/204
*	H	US-2006/0161915 A1	07-2006	Barr et al.	717/174
*	I	US-7,328,234 B1	02-2008	Nedbal et al.	709/202
*	J	US-7,620,948 B1	11-2009	Rowe et al.	717/171
*	K	US-2010/0077475 A1	03-2010	Deschenes et al.	726/21
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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